



SLD90N02T 20V N -Channel MOSFET

General Description

This Power MOSFET is produced using Msemitek's advanced TRENCH technology.

This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

Application

☑PWM Application

☑Power Management

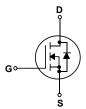
Features

- N-Channel:20V 90A

 $\begin{aligned} R_{DS(on)Typ} &= 3.4 m \Omega @VGS = 4.5 \text{ V} \\ R_{DS(on)Typ} &= 4.5 m \Omega @VGS = 2.5 \text{ V} \end{aligned}$

- Very Low On-resistance R_{DS(ON)}
- Low Crss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability





Absolute Maximum Ratings

 T_C = 25°C unless otherwise noted

Symbol	Parameter		SLD90N02T	Units
V _{DSS}	Drain-Source Voltage		20	V
I _D	Drain Current - Continuous (T _C = 25°C)	1	90	Α
ID	- Continuous (T _C = 100°C	;)	59	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	360	Α
V_{GSS}	Gate-Source Voltage		±10	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	150	mJ
P _D	Power Dissipation (T _C = 25°C)		81	W
R ₀ JC	Thermal Resistance, Junction to Case		1.85	°C/W
T _J , T _{STG}	Operating and Storage Temperature Range	е	-55 to +150	ဇ
T∟	Maximum lead temperature for soldering pu 1/8" from case for 5 seconds	urposes,	300	ဗ

^{*} Drain current limited by maximum junction temperature.

Package Marking

Symbol

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLD90N02T	SLD90N02T	TO-252	Tape & Reel	2500	25000

Electrical Characteristics

T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 uA	20			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =20 V, V _{GS} = 0 V			1	uA
Igssf	Gate-Body Leakage Current, Forward	V _{GS} =10V, V _{DS} = 0 V			100	nΑ
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -10 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA

On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \text{ uA}$	0.4	1	1.0	٧
R _{DS(on)}	Static Drain-Source	V _{GS} =4.5 V, I _D = 20A		3.4	4.3	mΩ
TOS(on)	On-Resistance	V _{GS} =2.5 V, I _D = 20A	-	4.5	6.2	11152

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = 10 V, V _{GS} = 0 V, f = 1.0 MHz	1	2420	1	pF
Coss	Output Capacitance		-	451	-	pF
Crss	Reverse Transfer Capacitance	1.5 1/1.2		454	-	pF

Switching Characteristics

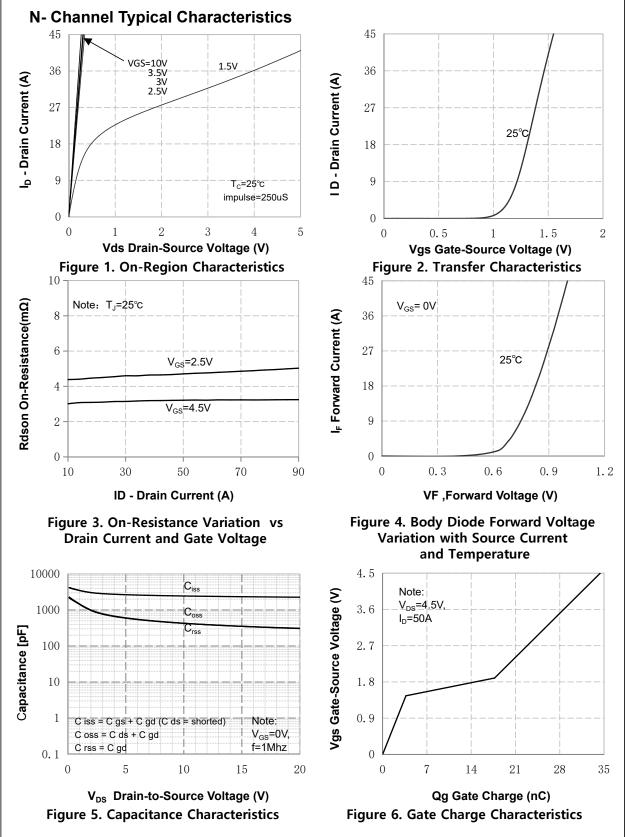
$t_{d(on)}$	Turn-On Delay Time		 10	 ns
tr	Turn-On Rise Time	V _{GS} =4.5V, V _{DS} =10V,	 38	 ns
$t_{d(off)}$	Turn-Off Delay Time	$R_L = 2.5\Omega$, $I_D = 50A$ Ti=25°C (Note 3)	 64	 ns
t _f	Turn-Off Fall Time	(1) 20 0	 53	 ns
Q_g	Total Gate Charge	V _{DS} = 10V, I _D =50A,	 34.4	 nC
Q_{gs}	Gate-Source Charge	$V_{GS} = 4.5V$ (Note 3)	 3.81	 nC
Q_{gd}	Gate-Drain Charge		 14	 nC

Drain-Source Diode Characteristics and Maximum Ratings

Is	Maximum Continuous Drain-Source Diode Forward Current	 	90	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current	 	360	Α
V _{SD}	Drain to Source Diode Forward Voltage, V _{GS} = 0V, I _{SD} =50A, T _J = 25°C	 -	1.2	V
Trr	Reverse recovery time,I _F =50A dl/dt=100A/µs	24		ns
Qrr	Reverse recovery charge, I F =50A dIF/dt=100A//µs	10		nC

Notes:

- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- 2. EAS condition: $T_J = 25$ °C, $V_{DD} = 10$ V, $V_G = 4.5$ V, L = 0.5mH,
- 3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%



N- Channel Typical Characteristics (Continued)

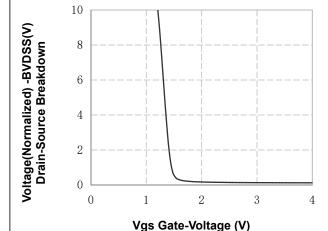


Figure 7. Breakdown Voltage Variation vs Gate-Voltage

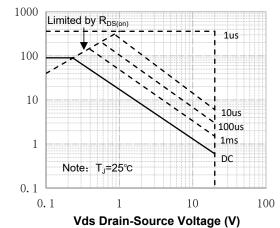


Figure 9. Maximum Safe Operating Area

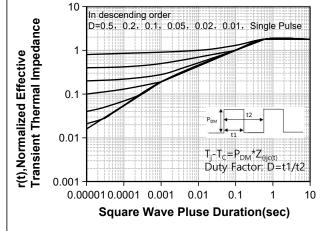
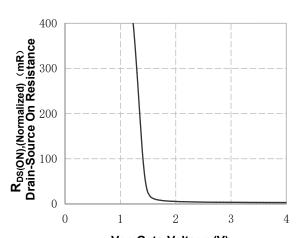


Figure 11. Transient Thermal Response Curve



Vgs Gate-Voltage (V)
Figure 8. On-Resistance Variation
vs Gate Voltage

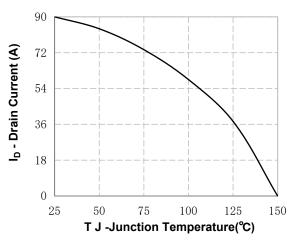
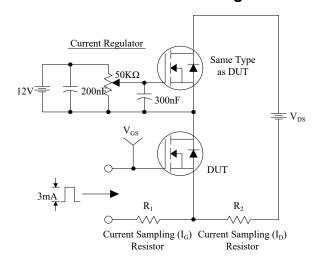
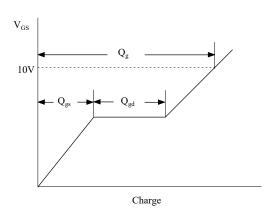


Figure 10. Maximum Continuous Drain Current vs Temperature

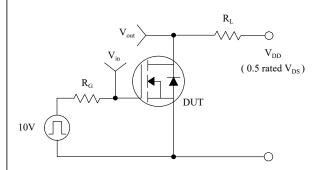
D - Drain Current (A)

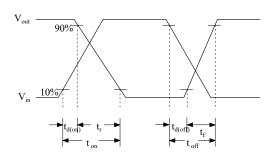
Gate Charge Test Circuit & Waveform



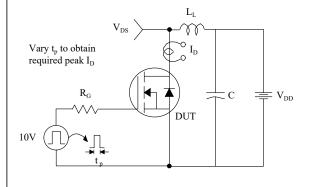


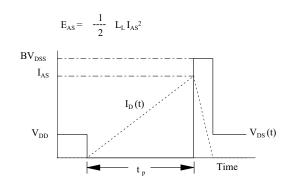
Resistive Switching Test Circuit & Waveforms



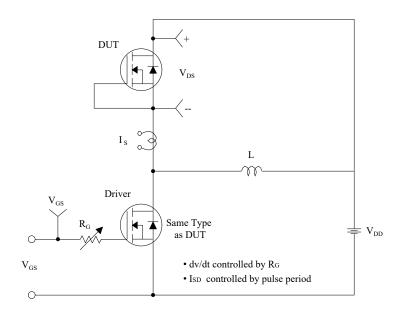


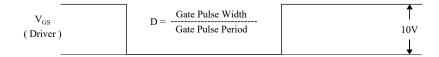
Unclamped Inductive Switching Test Circuit & Waveforms

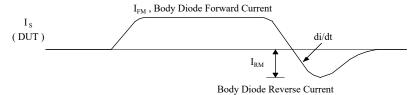


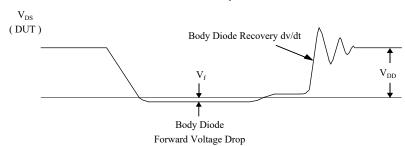


Peak Diode Recovery dv/dt Test Circuit & Waveforms

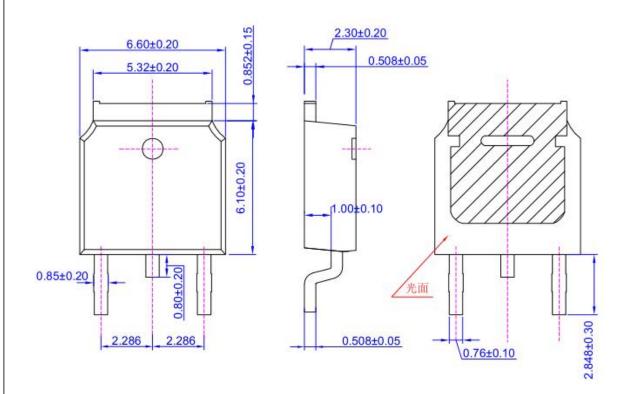


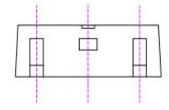






TO-252 OUTLINE





NOTE:

1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8 2.Undeclared tolerance \pm 0.25,Unmarked filletRmax=0.25

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